

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10695259	TAN, WAI-TIAN
	Examiner Nguyen-Ba, Hoang-Vu A	Art Unit 2421

SEARCHED

Class	Subclass	Date	Examiner
725	149	8/23/07	HAN
725	149, 86, 87, 101, 104	12/22/10	HAN
709	221, 220, 238, 239	12/22/10	HAN

SEARCH NOTES

Search Notes	Date	Examiner
East Text Search -- USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	8/23/07	HAN
East Text Search -- USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	10/22/08	HAN
709/220-221, 238-239 -- text search only	4/3/09	HAN
Appeal Brief Conference with John Miller	7/7/10	HAN
725/149, 86, 87, 101, 104; 709/221, 220, 238, 239 -- text search	12/22/10	HAN
Interference search -- see search history printout	12/22/10	HAN
Inventor search -- no DP	12/22/10	HAN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
725	149, 86, 87, 101, 104	12/22/10	HAN
709	221, 220, 238, 239	12/22/10	HAN

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